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Application No. 091945.512	Prepared by	<u>U</u> S	Tracking Number 5974755
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a. Serial No.	f. Foreign Priority	k. Print Claim(s)	(p. PTO-1449)	
b. Applicant(s)	g. Disclaimer	I. Print Fig.	q. PTOL-85b	
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. Abstract	
d. PCT	i. Title	n. PTO-270/328	s. Sheets/Figs	
e. Domestic Priority	j. Claims Allowed	o. PTO-892	t. Other	

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b. Text Continuity	OTO-1449: Please either initial (r Line through Citation (s) Copy provided for reference.
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT	<b>Application Number</b>	09/945512		
(Use as many sheets as necessary)	Filing Date	August 30, 2001		
PEVE	First Named Inventor	Forbes, Leonard		
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SEP 2 2 7000	Examiner Name	Booth, Richard		
Sheet 1 of 1	<del></del>	Attorney Docket No: 1303.027US1		

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**EXAMINER** 

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